

<b>Notice of References Cited</b>	Application/Control No. 10/691,307	Applicant(s)/Patent Under Reexamination WACK ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,327,023	12-2001	Bukofsky et al.	355/53
	B	US-6,077,631	06-2000	Unno, Yasuyuki	430/5
	C	US-6,067,375	05-2000	Tsudaka, Keisuke	382/144
	D	US-6,011,611	01-2000	Nomura et al.	355/67
	E	US-5,945,239	08-1999	Taniguchi, Tetsuo	430/30
	F	US-2002/0051567	05-2002	Ganz et al.	382/152
	G	US-6,636,302	10-2003	Nikoonahad et al.	356/237.2
	H	US-4,015,366	04-1977	Hall, III, Arthur D.	47/1.43
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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